TraNET[®] FE 204/404 Data Acquisition Instrument





The family of modular TraNET[®] data acquisition instruments provides turnkey solutions to many complex measurement problems. TraNET data acquisition systems are flexible, compact and portable. They can be used to solve in situ problems in many different applications like blast, ballistics, automotive, power or transportation systems. With the Continuous Data Recorder mode, a long duration event can be stored to disk, gap free in real-time, and analysed later. If applications require complex triggering across many channels, TraNET[®] can help you capture sequential blocks of data, without any loss, using the unique ECR Event Controlled Recording mode. The powerful application software TranAX[®] not only helps to quickly configure many acquisition channels, but also provides the right post-processing tools to analyse complex waveforms.

The TraNET[®] FE 204/404 can be equipped the poweful TPCE data acquisition card and is available as 4 to 16 channel device. Larger channel counts can be realized by either synchronizing several TraNET devices or with the TraNET[®] FE 408 DP device which available also as 32 channel instrument.

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TraNET® FE 204

TraNET* FE 204 devices are equipped with up to two 4-channel modules or one 8-channel TPCE DAQ module.

On Single Ended modules (SE), two inputs can be linked together for having a differential input. Differential ended modules (Diff) can also be used in single ended mode by using only the positive input.

For more detailed information see the specification table.

Dimensions & Weight

• 234 x 76 x 289 mm

• 3.1 kg



TraNET® FE 404

TraNET® FE 404 devices are equipped with up to four 4-channel modules or two 8-channel TPCE DAQ modules.

On Single Ended modules (SE) two inputs can be linked together for having a differential input. Differential ended modules (Diff) can also be used in single ended mode by using only the positive input.

Dimensions & Weight

• 234 x 115 x 289 mm

• 4.3 kg

Model Name	# Cha	# of Max. Sau Channels Rate		ADC Resolution	Memory
	SE	DIFF			per channel*
1x4S/02/16	4	2			
1x4D/02/16	4	4	2 MC /-	16 Bit	32 MS (128 MS)
2x4S/02/16	8	4	2 1015/5		
1x8S/02/16	8	4			16 MS (64 MS)
1x4S/10/16	4	2		44 D'I	
1x4D/10/16	4	4	10 MS /2	14 Bit 16 Bit up to 5	32 MS (128 MS)
2x4S/10/16	4	2	10 1013/5	MS/s	
1x8S/10/16	8	4			16 MS (64 MS)
1x4S/20/16	4	2			
1x4D/20/16	4	4	20 MS/s	14 Bit 16 Bit up to 5 MS/s	32 MS (128 MS)
2x4S/20/16	8	4			
1x8S/20/16	8	4			16 MS (64 MS)
1x4S/40/16	4	2			
1x4D/40/16	4	4		14 Bit	32 MS (128 MS)
2x4S/40/16	8	4	40 MS/s	16 Bit up to 10 MS/s	
1x8S/40/16	8	4			16 MS (64 MS)
1x4S/80/16	4	2			32 MS (128 MS)
1x4D/80/16	4	4		14 Bit 16 Bit up to 20 MS/s	
2x4S/80/16	8	4	80 MS/s		
1x8S/80/16	8	4			16 MS (64 MS)
1x4S/120/16	4	2			
1x4D/120/16	4	4	120 MS/s	14 Bit 16 Bit up to 60	32 MS (128 MS)
2x4S/120/16	8	4		MS/s	
1x4S/240/16	4	2		44 B'I	
1x4D/240/16	4	4	240 MS/s	14 Bit 0 MS/s 16 Bit up to 60	32 MS (128 MS)
2x4S/240/16	8	4		MS/s	

TraNET® 204 FE Device Configurations

Model Name	# of c	hannels	Max. Sample Rate	ADC Resolution	Memory	
	SE	DIFF			per channel*	
3x4S/02/16	12	6				
2x4D/02/16	8	8	2 MS /2	16 Bit	32 MS (128 MS)	
4x4S/02/16	16	8	2 1015/5			
2x8S/02/16	16	8			16 MS (64 MS)	
3x4S/10/16	12	6		44 D'I		
2x4D/10/16	8	8	10 MS/s 20 MS/s 40 MS/s	14 Bit 16 Bit up to 5	32 MS (128 MS)	
4x4S/10/16	16	8		MS/s		
2x8S/10/16	16	8			16 MS (64 MS)	
3x4S/20/16	12	6				
2x4D/20/16	8	8	20 MS/s	14 Bit 16 Bit up to 5 MS/s	32 MS (128 MS)	
4x4S/20/16	16	8				
2x8S/20/16	16	8			16 MS (64 MS)	
3x4S/40/16	12	6	20 MS/s 40 MS/s			
2x4D/40/16	8	8		14 Bit	32 MS (128 MS)	
4x4S/40/16	16	8	40 MS/s	16 Bit up to 10 MS/s		
2x8S/40/16	16	8	20 MS/s 40 MS/s	110,0	16 MS (64 MS)	
3x4S/80/16	12	6				
2x4D/80/16	8	8		14 Bit	32 MS (128 MS)	
4x4S/80/16	16	8	80 MS/s	16 Bit up to 20 MS/s		
2x8S/18/16	16	8			16 MS (64 MS)	
3x4S/120/16	12	6				
2x4D/120/16	8	8	120 MS/s	14 Bit 16 Bit up to 60	32 MS (128 MS)	
4x4S/120/16	16	8	120 IVIS/S	MS/s	02 MO (120 MO)	
3x45/240/16	12	6				
2×4D/240/16	0	0	040 MC/-	14 Bit	22 MC (122 MC)	
4245/240/10	16	0	240 IVIS/S	MS/s	32 IVIS (128 IVIS)	

TraNET® 404 FE Device Configurations

* Values in () are optional

General Specification

Connection	Ethernet 1 GBit, RJ45 front connector USB3 port for external HD
Harddisk	400 GB SSD
Power Supply	100 V - 250 V, 50/60 Hz
DC Power (Optional)	24 V DC
Power Consumption	~ 40 - 60 W (depends on the installed DAQ card)
Operating Condition	0 45 °C
	Rel. Humidity: - Up to 31°C: < 80% , - 31°C45°C: decreasing to < 50%
	Max. Operating Elevation: 2'000m
Storage Temperature	-20 60 °C
Channel Configuration	TraNET FE 204: 4 SE, 8 SE, 4 DIFF TraNET FE 404: 4 SE, 8 SE, 12 SE, 16 SE, 4 DIFF, 8 DIFF
Recording Modes	Scope, Multi Block, Continuous, Event Control- led Recording (ECR), Dual Sampling Rate (with ECR only)
Digital IO's (TTL)	Trigger In, Trigger Out, External Timebase In, Disarm In, Armed Out, SyncClock Out Optional: 8 Digital Marker Inputs
Synchronisation	SyncLink Port, IEEE 1588 (PTP) Optional: Internal GPS receiver
Software	TranAX 4 LE, TranAX 4 LabVIEW Instrument Driver C++/C#/Python API
Mechanical Specification	TraNET FE 204: 234 x 76 x 289 mm TraNET FE 404: 234 x 115 x 289 mm

Device Synchronization

The synchronization of several TraNET[®] FE devices has always been a strength of Elsys measuring devices. With the help of the synchronization unit **SyncLink SLB-8** or **SyncLink 2.0**, several TraNET[®] FE devices can be precisely synchronized on a sample basis. Not only is the internal timebase of all devices synchronized, but trigger messages are also transmitted with sample accuracy.

The latest generation MK3 of the TraNET[®] FE devices now also masters the network synchronization standard **IEEE-1588 (PTP: Precision Time Protocol)** and enables, on the one hand, much simpler synchronization topologies since no additional cables are required for synchronization and, on the other hand, the TraNET[®] FE devices can can be easily synchronized with other data acquisition systems or devices such as high-speed cameras.



SyncLink Synchronization Box

Specification SyncLink

- Timing precision: < 12.5 ns
- Connector/Cable: RJ45, Cat. 6Max Cable length: 50 m
- -

Specification PTP/GPS/PPS: • Timing precision: ±2 us

- (PTP: depends on network infrastructure)
- Long time drift: 0 ppm



Dust-Proof

TraNET[®] FE Dust-Proof devices are the perfect data acquisition instruments for dusty and muddy environment. They do not have any ventilation to the outside, preventing any air flow entering the device.

The Dust-Proof option is available for the 204 or 404 chassis type and all different sampling rates.

Operating conditions

- Operating Temperature: 0 .. 35 °C, higher temperature possible when free air flow is applied over the instrument.
- Storage Temperature: -20 .. 60 °C
- Rel. Humidity: Up to 31°C: < 80%
- 31°C ...45°C: decreasing to < 50%
- Max. Operating Elevation: 2'000m





Data Acquisition Cards

The Elsys TPCE or TPCE-LE measuring cards are used as data acquisition cards in the TraNET® FE 204 and 404. The cards are stably installed in the device and optimally cooled in order to achieve stable measurement accuracy and to guarantee a long service life for the measurement cards.

Single-Ended vs Differential Cards

All TPCE/TPCE-LE cards are available as single-ended (SE) or differential (DIFF) versions. Depending on how many inputs are measured differentially, an SE or DIFF card is worthwhile.



Single-ended cards have one BNC connector per channel where the outside shielding is connected to chassis/protective ground.

Two neighboring channel can be configured per software as differential input stage. In this case the signal must be connected as shown aside.



Differential cards have two BNC connector per channel where the outside shielding is connected to chassis/protective ground.

Single ended measurement can be performed by just using the + input of the BNC pair.

4-Channel vs 8-Channel Cards

8-channel cards are less expensive, but certain resources are distributed over 8 channels that would otherwise be available for 4 channels. For example, the on-board memory for 8-channel cards is only 16 MS per channel as standard and 64 MS is available as an additional option, which would be twice as much for a 4-channel card.

In addition, the maximum data throughput in continuous mode is 160 MS/s per card. This results in a maximum of 20 MS/s per channel for 8-channel cards and 40 MS/s for 4-channel cards.

TPCE vs TPCE-LE

All TPCE cards are available in two different edition, the standard TPCE and the TPCE-LE (Light Edition) version.

The TPCE-LE version has a reduced input range compared to the TPCE version. For fast streaming application, the TPCE version has a PCIe x4 interface which allows higher data throughput to the host computer, TPCE-LE has only a x1 interface. The ADC resolution can be set to 16 Bit hat lower sampling rates which is available as option for the TPCE-LE variant. For differential measurement, the Common Mode Rejection Ratio is higher for the TPCE variant then for the TPCE-LE version.

TPCE and TPCE-LE Product Configurations



4-Channel

- 32 MS per Channel
- 128 MS per Channel optional
- Max Streaming 4x40MS/s
- Max Streaming LE: 4x10MS/s

8-Channel

- 16 MS per Channel
- 64 MS per Channel optional
- Max Streaming 8x20MS/s
- Max Streaming LE: 8x5MS/s

	TPCE	TPCE-LE
Input Range	± 50 mV – ± 50V	± 100 mV - ± 25 V
PCIe Interface	x4 (160 MS/s max.)	x1 (40 MS/s max.)
Resolution	14 / 16 Bit	14 Bit
CMRR	> 74 dB	> 60 dB



Specifications

TPCE DAQ Cards

Module Type	TPCE-24016-4	TPCE-12016-4	TPCE-8016-4/8	TPCE-4016-4/8		
Number of Input Channels SE Module	4 single ended software s	or 2 differential witchable	4-Channel Modules: 4 sin 8-Channel Modules: 8 sin	gle ended or 2 differential gle ended or 4 differential		
Number of Input Channels DIF Module	4 single ended software s	or 4 differential witchable	4-Channel Modules: 4 single ended or 4 differential 8-Channel Modules: 8 single ended or 8 differential			
Max. Sample Rate (all channels are sampled simultaneously)	240 MHz	120 MHz	80 MHz	40 MHz		
Amplitude Resolution	16 Bit up to 60 MHz 14 Bit up to 240 MHz	16 Bit up to 60 MHz 14 Bit up to 120 MHz	16 Bit up to 20 MHz 14 Bit up to 80 MHz	16 Bit up to 10 MHz 14 Bit up to 40 MHz		
Memory 4 Channel Module		Standard: 4 x 32 MWords (= 256 MByte) Optional: 4 x 128 MWords (= 1 GByte)				
Memory 8 Channel Module	-		Standard: 8 x 16 MW Optional: 8 x 64 M	/ords (= 256 MByte) Words (= 1 GByte)		
Input Amplifier						
Measurement Ranges	±50 mV – ±	50 V rsp. 0.1 V – 100 V (*	100 V limited to 70 V) in	1, 2, 5 Steps		
Offset		0 - 100 % in steps of 0	.1% (Resolution 0.01 %)			
Input Impedance	1 MΩ (± 0.2 %) c // 26 pF	or 50 Ω (± 0.5 %) (± 5 %)	1 MΩ (± 0.2 %)	// 35 pF (± 5 %)		
Coupling	AC / DC so	ftware switchable (AC:	-3 dB at < 5 Hz), Input	ts invertible		
Bandwidth at Range $\geq 1 V$	120 MHz	60 MHz	30 MHz	18 MHz		
Bandwidth at Range < 1 V	80 MHz	50 MHz	8 MHz	7 MHz		
Slew Rate (10 – 90 %) @ Range \geq 1 V	4 ns	6 ns	13 ns	25 ns		
Slew Bate (10 – 90 %) @ Bange < 1 V	6 ns	9 ns	50 ns	60 ns		
Settling Time to 1%	< 200 ns	< 200 ns	< 200ns	< 200 ns		
Low Pass Filter (PC Filter)	< 200 H3	Stope (1 MHz and 100	< 200115	< 200 H3		
Antioliosing Filter (actional)	2 200 H-	Steps (1 wir iz and 100	Puttorworth ooftware a			
Antialiasing-Filter (optional)	200 12	z – 5 Miriz, IIIII. 4. older				
	Differential-informer: $\pm 8 \vee$ or $\pm 7.80 \vee$ at ranges. > 5 \vee					
Common Mode Rejection	> /4 dB (DC - 1 KHZ); > 60 dB (- 100 KHZ); > 40 dB (- 5 MHZ)					
Range Error (±)	max. 0.1 % typ.0.07 %max. 0.1 % typ.0.03 %(after autocalibration)(after autocalibration)			typ. 0.03 % calibration)		
Offset Error (±)	max. 0.1 % typ. 0.07 % max. 0.1 % typ. 0.02 % (after autocalibration) (after autocalibration)					
Offset Drift (±)	max. (0.01	max. (0.0100 % + 0.1 mV) per °C, typ. (0.0050 % + 0.03 mV) per °C (will be compensated by autocalibration)				
Input Noise: @ max. Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Rate	< 0.250 mVrms < 0.120 mVrms < 0.070 mVrms < 0.040 mVrms < 0.025 mVrms	< 0.200 mVrms < 0.120 mVrms < 0.070 mVrms < 0.040 mVrms < 0.025 mVrms	< 0.200 mVrms < 0.120 mVrms < 0.070 mVrms < 0.040 mVrms < 0.020 mVrms	< 0.180 mVrms < 0.110 mVrms < 0.060 mVrms < 0.040 mVrms < 0.015 mVrms	*2	
Signal to Noise Ratio SNR: @ max. Sample Rate @ 10 MHz Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Rate	58 dB 70 dB 72 dB 77 dB 81 dB 84 dB	60 dB 70 dB 72 dB 77 dB 81 dB 84 dB	59 dB 62 dB 66 dB 69 dB 79 dB 89 dB	62 dB 68 dB 70 dB 74 dB 82 dB 90 dB	*3	
Channel Isolation (Crosstalk) @ 10 kHz Banges < 1\/	> 74	l dB	> 80) dB) dB		
Special : Autocalibration	Auto adjustment of	f gain and offset in all m	easurement ranges (Ini	itiated by software)		
Trigger		gain and onset in an in		indica by soliwarc)		
Number of Trigger Channels	4 coupled to	o analog inputs, pos./ne Window IN N	eg.Edge, with or without Window QUT	t hysteresis,		
Advanced Trigger (Option)	On all analog inputs: Slew Rate, Pulse Width, Pulse Pause or Period (too short or too long = Missing Event), State (above / below), AND link, Product (trigger signal is calculated from					
External Trigger input		1 per System (TTL)	, pos. or nea. Edae			
Trigger Delay	-100	% (Pretrigger) to ± 200	% (Posttriager) in 1 % s	tens		
Miscellaneous	-100					
		8 (2 per apalag	channel) (TTL)			
Digital Inputs (Marker)	Optoco	oupler Connection Box (5 to 48 V) as additional	option		
Ext. Control Inputs (TTL))	Trigger, Arm/Disarm, E	Ext. Sampling (fmax = `	10 MHz), external comm	and to start recording		
Status Outputs (TTL)	Т	rigger Output, Armed (=True during recording)		
ICP [®] Sensor Supply (Option)	4	4mA Integrated Current Power for piezo sensors				

Module Type	TPCE-2016-4/8	TPCE-1016-4/8	TPCE-0516-4/8	TPCE-0216-4/8	
Number of Input Channels SE Module	4-Channel Modules: 4 single ended or 2 differential 8-Channel Modules: 8 single ended or 4 differential				
Number of Input Channels DIF Module	4-Channel Modules: 4 single ended or 4 differential 8-Channel Modules: 8 single ended or 8 differential				
Max. Sample Rate (all channels are sampled simultaneously)	20 MHz	10 MHz	5 MHz	2 MHz	
Amplitude Resolution	16 Bit up to 5 MHz 14 Bit up to 20 MHz	16 Bit up to 5 MHz 14 Bit up to 10 MHz	16 Bit up to 5 MHz	16 Bit up to 2 MHz	
Memory 4 Channel Module		Standard: 4 x 32 MW Optional: 4 x 128 M	/ords (= 256 MByte) Words (= 1 GByte)		
Memory 8 Channel Module		Standard: 8 x 16 MW Optional: 8 x 64 M ^N	′ords (= 256 MByte) Words (= 1 GByte)		
Input Amplifier					
Measurement Ranges	±50 mV – ±	50 V rsp. 0.1 V – 100 V (1	00 V limited to 70 V) in	1, 2, 5 Steps	
Offset		0 – 100 % in steps of 0	1% (Resolution 0.01 %)		
Input Impedance		1 MΩ (± 0.2 %) /	7/ 35 pF (± 5 %)		
Coupling	AC / DC so	ftware switchable (AC:	-3 dB at < 5 Hz), Input	s invertible	
Bandwidth at Range \geq 1 V	10 MHz	5 MHz	2.5 MHz	1 MHz	
Bandwidth at Range < 1 V	6 MHz	4 MHz	2.5 MHz	1 MHz	
Slew Rate (10 – 90 %) @ Range \geq 1 V	40 ns	70 ns	80 ns	180 ns	
Slew Rate (10 – 90 %) @ Range < 1 V	70 ns	80 ns	80 ns	180 ns	
Settling Time to 1%	< 200ns	< 200 ns	< 300 ns	< 500 ns	
Low Pass Filter (RC-Filter)	2	Steps (1 MHz and 100	(Hz) software switchabl	e	
Antialiasing-Filter (optional)	200 Hz	z – 5 MHz, min. 4. order	Butterworth, software s	etable	
Common Mode Range	Dif	ferential-Mode: ±8 V o	r +/-80 V at ranges. > 5	V	
Common Mode Rejection	> 74 dB (DC – 1 kHz); > 60 dB (– 100 kHz); > 40 dB (– 20 MHz)				
Range Error (±)	max. 0.1 % typ. 0.03 % (after autocalibration)				
Offset Error (±)	max. 0.1 % typ. 0.03 % (after autocalibration)				
Offset Drift (±)	max. (0.01	00 % + 0.1 mV) per °C, (will be compensated	typ. (0.0050 % + 0.03 m d by autocalibration)	V) per °C	
Input Noise: @ max. Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Rate	< 0.080 mVrms < 0.060 mVrms < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	< 0.080 mVrms < 0.060 mVrms < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	< 0.060 mVrms < 0.060 mVrms < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	< 0.060 mVrms - < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	*2
Signal to Noise Ratio SNR: @ max. Sample Rate @ 10 MHz Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Rate	67 dB 70 dB 72 dB 79 dB 84 dB 90 dB	70 dB 70 dB 72 dB 79 dB 84 dB 90 dB	72dB - 72 dB 79 dB 84 dB 90 dB	72 dB - - 79 dB 84 dB 90 dB	*3 *4
Channel Isolation (Crosstalk) @ 10 kHz Ranges < 1V		> 80 > 60	dB dB		
Special : Autocalibration	Auto adjustment of	gain and offset in all m	easurement ranges. (Ini	tiated by software)	
Trigger					
Number of Trigger Channels	4 or 8, coupled	d to analog inputs, pos./ Window IN, V	'neg.Edge, with or withc Vindow OUT	out hysteresis,	
Advanced Trigger (Option)	On all analog inputs: = Missing Event), State	Slew Rate, Pulse Width, e (above / below), AND 2 char	Pulse Pause or Period link, Product (trigger sig nnels)	(too short or too long gnal is calculated from	
External Trigger input		1 per System (TTL).	pos. or nea. Edae		
Trigger Delay	-100	% (Pretrigger) to $+200$	% (Posttrigger) in 1 % st	tens	
Miscellaneous	100				
		8 rsp 16 (2 per apal	og channel) (TTL)		
Digital Inputs (Marker)	Optoco	oupler Connection Box (5 to 48 V) as additional	option	
Ext. Control Inputs (TTL))	ingger, Arm/Disarm, E	to start re	ecording	e), external command	
	Т	rigger Output, Armed (= Irue during recording))	
ICP [~] Sensor Supply (Option)	4	ImA Integrated Current	Power for piezo sensors	5	

TPCE-LE DAQ Cards

Module Type	TPCE-LE-24014-4	TPCE-LE-12014-4	TPCE-LE-8014-4/8	TPCE-LE-4014-4/8		
Number of Input Channels SE Module	4 single ended or 2 differential software switchable 4-Channel Modules: 4 single ended or 2 differen 8-Channel Modules: 8 single ended or 4 differen		gle ended or 2 differential gle ended or 4 differential			
Number of Input Channels DIF Module	4 single ended software s	or 4 differential switchable	4-Channel Modules: 4 sin 8-Channel Modules: 8 sin	gle ended or 4 differential gle ended or 8 differential		
Max. Sample Rate (all channels are sampled simultaneously)	240 MHz	120 MHz	80 MHz	40 MHz		
Amplitude Resolution	14 Bit up to 240 MHz (16 Bit up to 60 MHz optional)	14 Bit up to 120 MHz (16 Bit up to 60 MHz optional)	14 Bit up to 80 MHz (16 Bit up to 20 MHz optional)	14 Bit up to 40 MHz (16 Bit up to 10 MHz optional)		
Memory 4 Channel Module		Standard: 4 x 32 MW Optional: 4 x 128 M	Vords (= 256 MByte) IWords (= 1 GByte)			
Memory 8 Channel Module		-	Standard: 8 x 16 MW Optional: 8 x 64 M	/ords (= 256 MByte) Words (= 1 GByte)		
Input Amplifier						
Measurement Ranges	<u>+</u>	-100 mV – ±25 V rsp. 0.2	2 V – 50 V in 1, 2, 5 Step	S		
Offset		0 - 100 % in steps of 0	.1% (Resolution 0.01 %)			
Input Impedance	1 MΩ (± 0.2 %) c // 26 pF	or 50 Ω (± 0.5 %) (± 5 %)	1 MΩ (± 0.2 %)	// 35 pF (± 5 %)		
Coupling	AC / DC so	ftware switchable (AC:	-3 dB at < 5 Hz), Inpu	ts invertible		
Bandwidth at Range $\geq 1 V$	120 MHz	60 MHz	30 MHz	18 MHz		
Bandwidth at Bange < 1 V	80 MHz	50 MHz	8 MHz	7 MHz		
Slew Bate (10 – 90 %) @ Bange \geq 1 V	4 ns	6 ns	13 ns	25 ns		
Slew Bate (10 – 90 %) @ Bange < 1 V	6 ns	9 ns	50 ns	60 ns		
Settling Time to 19/	< 200 pc	3115 < 200 pc	< 200mg	< 200 pc		
	< 200 HS	< 200 HS		< 200 115		
Low Pass Filter (RC-Filter)	2	Steps (TIMHZ and TOUT	KHZ) SOILWARE SWITCHAD	le		
Antialiasing-Filter (optional)	200 H:	z – 5 MHz, min. 4. order	Butterworth, software s	etable		
Common Mode Range	Differential-Mode: $\pm 8 \vee$ or $\pm 7-80 \vee$ at ranges. > 5 V					
Common Mode Rejection	> 60 dB (DC – 1 kHz); > 54 dB (– 100 kHz); > 40 dB (– 20 MHz)					
Range Error (±)	(after autocalibration) (after autocalibration)					
Offset Error (±)	max. 0.1 % (after auto	max. 0.1 % typ. 0.07 % max. 0.1 % typ. 0.02 % (after autocalibration) (after autocalibration)				
Offset Drift (±)	max. (0.0100 % + 0.1 mV) per °C, typ. (0.0050 % + 0.03 mV) per °C (will be compensated by autocalibration)					
Input Noise: @ max. Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Rate	< 0.250 mVrms < 0.120 mVrms < 0.070 mVrms < 0.040 mVrms < 0.025 mVrms	< 0.200 mVrms < 0.120 mVrms < 0.070 mVrms < 0.040 mVrms < 0.025 mVrms	< 0.200 mVrms < 0.120 mVrms < 0.070 mVrms < 0.040 mVrms < 0.020 mVrms	< 0.180 mVrms < 0.110 mVrms < 0.060 mVrms < 0.040 mVrms < 0.015 mVrms	*2	
Signal to Noise Ratio SNR: @ max. Sample Rate @ 10 MHz Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Rate	58 dB 70 dB 72 dB 77 dB 81 dB 84 dB	60 dB 70 dB 72 dB 77 dB 81 dB 84 dB	59 dB 62 dB 66 dB 69 dB 79 dB 89 dB	62 dB 68 dB 70 dB 74 dB 82 dB 90 dB	*3	
Channel Isolation (Crosstalk) @ 10 kHz	> 74	1 dB	> 80) dB		
Special : Autocalibration	Auto adjustment of	f gain and offset in all m	easurement ranges. (Ini	itiated by software)		
Triager	,		5	,		
Number of Trigger Channels	4 coupled t	o analog inputs, pos./ne Window IN, V	eg.Edge, with or without Window OUT	t hysteresis,		
Advanced Trigger (Option)	On all analog inputs: = Missing Event), Stat	Slew Rate, Pulse Width e (above / below), AND 2 chai	, Pulse Pause or Period link, Product (trigger si nnels)	(too short or too long gnal is calculated from		
External Trigger input		1 per System (TTL)	, pos. or neg. Edge			
Trigger Delay	-100	% (Pretrigger) to +200	% (Posttrigger) in 1 % s	teps		
Miscellaneous						
		8 (2 per analog	channel) (TTL)			
Digital Inputs (Marker)	Optoco	oupler Connection Box (5 to 48 V) as additional	option		
Ext. Control inputs (TTL)	ngger, Arm/Disarm, I	=xt. Sampling (tmax = 1	iu ivinz), external comm	and to start recording		
ICP® Sensor Supply (Option)	2	Armed (AmA Integrated Current	Power for piezo sensors	5		

Module Type	TPCE-LE-2014-4/8	TPCE-LE-1014-4/8	TPCE-LE-0514-4/8	TPCE-LE-0214-4/8		
Number of Input Channels SE Module	4-Channel Modules: 4 single ended or 2 differential 8-Channel Modules: 8 single ended or 4 differential					
Number of Input Channels DIF Module	4-1 8-1	4-Channel Modules: 4 single ended or 4 differential 8-Channel Modules: 8 single ended or 8 differential				
Max. Sample Rate (all channels are sampled simultaneously)	20 MHz	10 MHz	5 MHz	2 MHz		
Amplitude Resolution	14 Bit up to 20 MHz (16 Bit up to 5 MHz optiona)	14 Bit up to 10 MHz (16 Bit up to 5 MHz optional)	14 Bit (16 Bit Optional)	14 Bit (16 Bit Optional)		
Memory 4 Channel Module		Optional: 4 x 32 MM	Words (= 256 MByte)			
Memory 8 Channel Module		Standard: 8 x 16 MWords (= 256 MByte) Optional: 8 x 64 MWords (= 1 GByte)				
Input Amplifier						
Measurement Ranges	±	:100 mV – ±25 V rsp. 0.2	2 V – 50 V in 1, 2, 5 Step	S		
Offset		0 – 100 % in steps of 0	.1% (Resolution 0.01%)			
	40 / 50	$1 M\Omega (\pm 0.2 \%) /$	7/35 pF (± 5 %)			
Coupling	AC / DC so	ttware switchable (AC:	-3 dB at < 5 Hz), Input	is invertible		
Bandwidth at Range $\geq 1 V$	10 MHz	5 MHz	2.5 MHz	1 MHz		
Bandwidth at Range < 1 V	6 MHz	4 MHz	2.5 MHz	1 MHz		
Slew Rate (10 – 90 %) @ Range ≥ 1 V	40 ns	70 ns	80 ns	180 ns		
Slew Rate (10 – 90 %) @ Range < 1 V	70 ns	80 ns	80 ns	180 ns		
Settling Time to 1%	< 200ns	< 200 ns	< 300 ns	< 500 ns		
Low Pass Filter (RC-Filter)	2	Steps (1 MHz and 100 l	kHz) software switchabl	e		
Antialiasing-Filter (optional)	200 Hz	z – 5 MHz, min. 4. order	Butterworth, software s	etable		
Common Mode Range	Dif	ferential-Mode: ±8 V o	r +/-80 V at ranges. > 5	ν		
Common Mode Rejection	> 60 dB	(DC – 1 kHz); > 54 dB ((– 100 kHz); > 40 dB (–	1 MHz)		
Range Error (±)	max. 0.1 % typ. 0.03 % (after autocalibration)					
Offset Error (±)	max. 0.1 % typ. 0.03 % (after autocalibration)					
Offset Drift (±)	max. (0.01	00 % + 0.1 mV) per °C, (will be compensated	typ. (0.0050 % + 0.03 m d by autocalibration)	IV) per °C		
Input Noise: @ max. Sample Rate @ 5 MHz Sample Rate @ 1 MHz Sample Rate @ 100 kHz Sample Rate @ 10 kHz Sample Bate	< 0.080 mVrms < 0.060 mVrms < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	< 0.080 mVrms < 0.060 mVrms < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	< 0.060 mVrms < 0.060 mVrms < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	< 0.060 mVrms - < 0.030 mVrms < 0.020 mVrms < 0.010 mVrms	*2	
 Signal to Noise Ratio SNR: (a) max. Sample Rate (a) 10 MHz Sample Rate (b) 5 MHz Sample Rate (c) 1 MHz Sample Rate (c) 100 kHz Sample Rate (c) 10 kHz Sample Rate (c) 10 kHz Sample Rate 	67 dB 70 dB 72 dB 79 dB 84 dB 90 dB	70 dB 70 dB 72 dB 79 dB 84 dB 90 dB	72dB - 72 dB 79 dB 84 dB 90 dB	72 dB - - 79 dB 84 dB 90 dB	*3 *4	
Channel Isolation (Crosstalk) @ 10 kHz Ranges < 1V		> 80 > 60) dB) dB			
Special : Autocalibration	Auto adjustment of	gain and offset in all m	easurement ranges. (Ini	tiated by software)		
Trigger						
Number of Trigger Channels	4 or 8, coupled	d to analog inputs, pos., Window IN, V	/neg.Edge, with or witho Vindow OUT	out hysteresis,		
Advanced Trigger (Option)	On all analog inputs: = Missing Event), State	Slew Rate, Pulse Width, e (above / below), AND 2 char	, Pulse Pause or Period link, Product (trigger sig nnels)	(too short or too long gnal is calculated from		
External Trigger input		1 per System (TTL)	, pos. or nea. Edge			
Trigger Delay	-100	% (Pretrigaer) to $+200$	% (Posttriager) in 1 % s	teps		
Miscellaneous	100		, o (i oottiiggoi) iii i , o o	lopo		
Digital Inputs (Marker)	Ontoco	8 rsp. 16 (2 per anal	log channel) (TTL) 5 to 48 V) as additional	option		
Ext. Control Inputs (TTL))	Trigger, Arm/Disarm, E	Ext. Sampling (fmax = 1	4 of the max sample rat	e), external command		
Status Outputs (TTL)	т	rigger Output Armod (
ICP [®] Sensor Supply (Option)	4	mA Integrated Current	Power for piezo sensors	5		

At 16 bit modules, the resolution will be reduced to 14 bits at sample rates over 1/4 of the max. sample rate. The input noise depends on the sample rate. At 14 bit modules the SNR will be reduced by 2 dB At 8-channel modules the SNR will be reduced by 3 dB *1)

- *2)
- *3)
- *4)

TranAX[®] 4

TranAX[®] 4 is the universal data acquisition software from Elsys designed for all types of data acquisition cards and the turnkey TraNET[®] data acquisition instruments.

Key Features

- Configures quick and easy many analog input channels, no programming required
- Data visualization in Multi-Waveform displays
- Several cursor for easy data readout and reporting
- X-Y data display
- FFT Analysis
- Spectrogram and Waterfall diagrams
- · Measurement data video synchronization
- More than 40 scalar functions to measure any significant waveform
 parameter on time or FFT curves
- Powerful formula editor for more than 60 mathematics functions, syntax highlighting, for-loops, array calculations, string manipulations, etc.
- Python integration
- Measurement Flow Control macro's for easy to set up, fast automated measurements
- Documentation Generator
- English, German and Chinese version



TranAX® Waveforms

The measurement curves can be displayed individually without any programming effort. Any number of curves can be displayed per waveform. The waveforms can in turn be arranged on a page.

The envelope curve algorithm running in the background calculates reduced data sets, allowing even very large files of several GB to be displayed quickly.

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Control Panel



Additional Tools and APIs

- Waveform Viewer
- Excel TPC5 Importer
- File Converter Tool
- ActiveX/.NET Remote
- LabVIEW Instrument Driver
- C++/C#/Python API
- Excel Report Generator

Additional Accessories

Digital Input/Output BNC Box

The BNC break-out box simplifies access to the additional digital control and marker signals.

Available Signals:

Trigger In, Trigger Out, Armed Out, Disarm In, Ext. Timebase In, Ext. Start In, 8x Marker In





Precision High-Voltage Attenuators

The precision attenuators allow measurements up to 1000 V with a much higher precision than standard oscilloscope probes.

- 20 : 1, 100 : 1 and 1000 : 1 attenuators
- 2 or 3 channel per box
- up to 1000 V Vmax

SyncLink Box

To connect several TraNET® FE, EPC or PPC devices to a large measuring system, the devices must be synchronized with each other. The SLB-8 connects up to 8 TraNET devices. All connected devices run with a sample accurate reference clock. In addition, trigger events are signaled, which means that each measurement input can be used as a trigger source for the remaining inputs on all connected devices.
 SyncLink SLB-8
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